











#### DAC80004, DAC70004, DAC60004

SLASED6D - APRIL 2016 - REVISED DECEMBER 2017

# DACx0004, Quad 16-,14-,12-Bit, 1 LSB INL, Buffered, Voltage-Output Digital-to-Analog Converters

#### **Features**

- True 16-Bit Performance: 1 LSB INL/DNL (Max)
- Ultra Low Glitch Energy: 1 nV-s
- Wide Power-Supply Range: 2.7 V to 5.5 V
- Output Buffer with Rail-to-Rail Operation
- Current Consumption: 1 mA/Channel
- 50-MHz, 4- or 3-Wire SPI Compatible Interface
- SDO Pin for Readback and Daisy Chain
- Power-On Reset to Zero or Mid Scale
- Temperature Range: -40°C to +125°C
- Multiple Packages:
  - Tiny 14-Pin VSON
  - 14-Pin TSSOP

## 2 Applications

- Portable Instrumentation
- PLC Analog Output Module (4-20 mA)
- Closed-Loop Servo Control
- **Data Acquisition Systems**

## 3 Description

The DAC80004/70004/60004 (DACx0004) are highly accurate, low-power, voltage-output, quad-channel, 16-, 14-, 12-bit digital-to-analog converters (DACs) respectively. The DACx0004 devices are ensured monotonic by design and offer excellent linearity of less than 1 LSB (Max). The reference input of the DAC is buffered internally using a dedicated reference buffer.

The DACx0004 devices incorporate a power-on-reset circuit that ensures the DAC output powers up at zero scale or mid scale depending on status of the POR pin and remains in this state until a valid code is written to the device. These devices consume very low current of 1 mA/channel making them ideal for portable, battery-operated equipment. These devices also contain a power-down feature that reduces current consumption to typically 3 µA at 5 V.

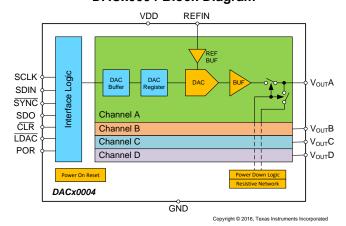
The DACx0004 devices use a versatile 4- or 3-wire serial interface that operates at clock rates up to 50 MHz. The DACx0004 devices also include a SDO pin to daisy chain multiple devices. The interface is compatible with standard SPITM, QSPITM, Microwire, and digital signal processor (DSP) interfaces. The DACx0004 devices are offered in easy-to-assemble 14-pin TSSOP packages or an ultra small 14-pin VSON package and are fully specified over the extended industrial temperature range of -40°C to 125°C.

#### Device Information<sup>(1)</sup>

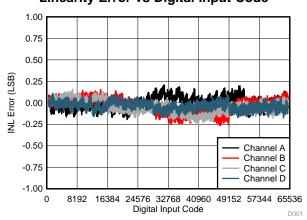
PART NUMBER	PACKAGE	BODY SIZE (NOM)
DACx0004	VSON (14)	3.00 mm x 4.00 mm
DACx0004	TSSOP (14)	5.00 mm x 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

## **DACx0004 Block Diagram**



#### **Linearity Error vs Digital Input Code**



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# 4 Revision History

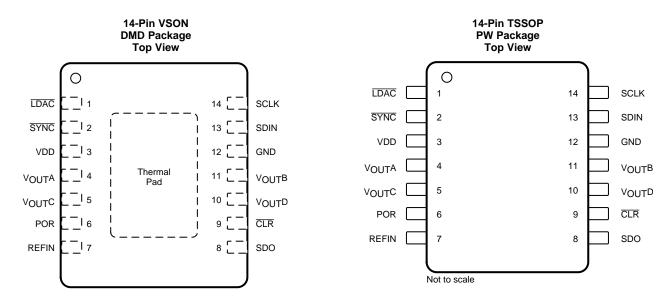
Changes from Revision C (August 2016) to Revision D	Page
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Changed From: t <sub>19</sub> To: t <sub>20</sub> in Figure 1	8
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Deleted thermal pad from PW-TSSOP pin configuration	3
Changes from Revision A (June 2016) to Revision B	Page
Added DAC80004IPW Device Marking Addendum to Mechanical, Packaging, and Orderable Information	31
Changes from Original (April 2016) to Revision A	Page
Changed from Product Preview to Production Data	



## 5 Device Comparison Table

DEVICE	RESOLUTION
DAC80004	16
DAC70004	14
DAC60004	12

# 6 Pin Configuration and Functions



#### **Pin Functions**

	PIN	I/O	DESCRIPTION		
NAME	NUMBER	1/0	DESCRIPTION		
CLR	9	Digital Input	Clear DAC pin, falling edge sensitive		
GND	12	Power	Ground		
LDAC	1	Digital Input	Load DAC pin, active low		
POR	6	Digital Input	Power-on-reset configuration, Connecting the POR pin to GND powers up all four DACs to zero scale. Connecting this pin to VDD powers up all four DACs to midscale.		
REFIN	7	Analog Input	Voltage reference input for all channels		
SCLK	14	Digital Input	Serial interface shift clock		
SDIN	13	Digital Input	Serial interface digital input		
SDO	8	Digital Output	Serial interface digital output for readback and daisy chaining		
SYNC	2	Digital Input	Serial interface synchronization, active low		
VDD	3	Power	Positive power supply (2.7 V to 5.5 V)		
V <sub>OUT</sub> A	4	Analog Output	DAC A output		
V <sub>OUT</sub> B	11	Analog Output	DAC B output		
V <sub>OUT</sub> C	5	Analog Output	DAC C output		
V <sub>OUT</sub> D	10	Analog Output	DAC D output		



## 7 Specifications

#### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

	MIN	MAX	UNIT
Voltage, VDD to GND	-0.3	7	V
Voltage, digital input or output to GND	-0.3	$V_{DD} + 0.3$	V
Voltage, analog input (REFIN) or output (V <sub>OUT</sub> x) to GND	-0.3	$V_{DD} + 0.3$	V
Input current to any pin except supply pins	-10	10	mA
Maximum junction temperature		150	°C
Storage temperature range, T <sub>stg</sub>	-60	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1)	±2000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±1000	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
Voltage, VDD to GND		2.7	5.5	V
Voltage, analog input (REFIN) or output	$2.7 \text{ V} \leq \text{V}_{DD} \leq 4.5 \text{ V}$	2.2	$V_{DD} - 0.2$	٧
(V <sub>OUT</sub> x) to GND	4.5 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.2	$V_{DD}$	٧
Ambient Operating Temperature, T <sub>A</sub>		-40	125	°C

#### 7.4 Thermal Information

		DAC		
	THERMAL METRIC <sup>(1)</sup>	DMD (VSON)	PW (TSSOP)	UNIT
		14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	39.6	99.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	27.3	23.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	9.0	42.8	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.3	0.9	°C/W
ΨЈВ	Junction-to-board characterization parameter	8.9	42.0	°C/W
R <sub>0</sub> JC(bot)	Junction-to-case (bottom) thermal resistance	6.5	N/A	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 7.5 Electrical Characteristics

All minimum/maximum specifications at  $T_A$  = -40°C to +125°C, 2.7 V  $\leq$  V<sub>DD</sub>  $\leq$  5.5 V, 2.5 V  $\leq$  REFIN<sup>(1)</sup>  $\leq$  VDD, R<sub>load</sub> = 5 k $\Omega$  to GND, C<sub>load</sub> = 200 pF to GND (unless otherwise noted), Digital inputs held at 0 V

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC F	PERFORMANCE <sup>(2)</sup>					
		DAC80004	16			
	Resolution	DAC70004	14			Bits
		DAC60004	12			
INL	Relative accuracy <sup>(3)</sup>				±1	LSB
DNL	Differential nonlinearity (3)	Ensured monotonic			±1	LSB
THE	Total unadjusted error <sup>(3)</sup>	$T_A = +20^{\circ}C \text{ to } +40^{\circ}C$			1.5	\/
TUE	rotal unadjusted error	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$			2	mV
ZCE	Zero code error	T <sub>A</sub> = -40°C to +125°C, Code 0d into DAC		±0.2	±2	mV
		T <sub>A</sub> = +25°C, Code 0d into DAC		±0.1		
ZCE-TC	Zero code error TC	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		±5		μV/°C
	Offset error <sup>(3)</sup>	$T_A = +20^{\circ}C \text{ to } +40^{\circ}C$			±1.2	mV
OE		$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		±0.2	±1.8	
		T <sub>A</sub> = +25°C		±0.2		
OE-TC	Offset error drift	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		±4		μV/°C
		$T_A = +20$ °C to +40°C, Code 65535d into DAC			±0.05	%FSR
FSE	Full-scale error <sup>(4)</sup>	$T_A = -40$ °C to +125°C, Code 65535d into DAC		±0.01	±0.07	%FSR
		T <sub>A</sub> = +25°C		±0.01		
FSE-TC	Full-scale error drift <sup>(4)</sup>	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		±2		ppm FSR/°C
OF.	Gain error <sup>(3)</sup>	$T_A = -40^{\circ}\text{C to } +125^{\circ}\text{C}$		±0.005	±0.05	0/ FCD
GE	Gain error (%)	T <sub>A</sub> = +25°C		±0.005		%FSR
GE-TC	Gain drift	$T_A = -40$ °C to +125°C		±2		ppm FSR/°C
	Output voltage drift vs.Time	$T_A = +25$ °C, Vout = $\frac{3}{4}$ of full scale, 1900 hr		20		ppm FSR
	Load Regulation	T <sub>A</sub> = +25°C, Vout =Mid Scale		0.003%		
PSRR	DC Power supply rejection ratio (4)	T <sub>A</sub> = +25°C, Vout = full scale		-92		dB

<sup>(1) 200</sup> mV headroom is required between REFIN and VDD when 2.7 V  $\leq$  V<sub>DD</sub>  $\leq$  4.5 V.

<sup>(2)</sup> Output unloaded

<sup>(3)</sup> End point fit between codes Code 512 to Code 65,024 - DAC80004, Code 128 to Code 16,256 - DAC70004, Code 32 to Code 4064 - DAC60004, Output unloaded.

<sup>(4)</sup> With 100 mV headroom between DAC output and VDD.



## **Electrical Characteristics (continued)**

All minimum/maximum specifications at  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ ,  $2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}$ ,  $2.5 \text{ V} \leq \text{REFIN}^{(1)} \leq \text{VDD}$ ,  $R_{load} = 5 \text{ k}\Omega$  to GND,  $C_{load} = 200 \text{ pF}$  to GND (unless otherwise noted), Digital inputs held at 0 V

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
DYNAMI	C PERFORMANCE				
	Output voltage settling time	$\%$ to $\%$ scale and $\%$ to $\%$ scale settling to ±1 LSB, $R_L$ = 5 $k\Omega,C_{load}$ = 200 pF to GND	5.8	8	μs
	Slew rate		1.5		V/µs
	Power-up time <sup>(5)</sup>		100		μs
	Power-on glitch energy	Supply slew rate <5 V/msec	8		mV
	Power-off glitch energy	DAC in power down mode (1 k $\Omega$ -GND), Supply slew rate <5 V/msec	7		mV
	Output poice	0.1 Hz to 10 Hz	5		μVpp
	Output noise	100 kHz BW	100		μVRMS
	Output a size density	Measured at 1 kHz	60		->///
	Output noise density	Measured at 10 kHz	55		nV/√Hz
THD	Total harmonic distortion	REFIN = 3 V ± 0.2 V <sub>pp</sub> , Frequency = 10 kHz, DAC at mid scale, specified by design	-80		dB
PSRR	AC power supply rejection ratio	200 mV 50 Hz and 60 Hz sine wave superimposed on power supply voltage (AC analysis)	-90		dB
	Code change glitch impulse	1 LSB change around major carry, Software LDAC mode	1		nV-s
	Channel-to-channel AC (analog) crosstalk	Full-scale swing on adjacent channel, Hardware LDAC mode	1		nV-s
	Channel-to-channel DC crosstalk	Full-scale swing on adjacent channels, Measured channel at zero scale	1		LSB
		Full-scale swing on all channel, Measured channel at zero scale	1		
	Digital crosstalk	DAC code mid scale, Adjacent input buffer change from 0000h to FFFFh or vice versa	0.2		nV-S
	Reference feedthrough	REFIN = 3 V ± 0.86 V <sub>pp</sub> , Frequency = 100 Hz to 100 kHz, DAC at zero scale	-85		dB
	Digital feedthrough	At SCLK = 1 MHz, DAC output static at mid scale	0.2		nV-s
OUTPUT	CHARACTERISTICS				
	Voltage range		0	$V_{DD}$	V
	Headroom	Output loaded 5 kΩ, DAC code FFFFh	0.1		V
	Headiooni	Output loaded 0.5 k $\Omega$ , DAC code FFFFh	10		%FSR
RL	Resistive load		0.5		kΩ
	Capacitive load	R <sub>L</sub> = ∞	1		»E
CL		$R_L = 5 k\Omega$	2		nF
		Normal mode	0.5		Ω
RO	DC output impedance	Power down with 100 kΩ network	100		kΩ
		Power down with 1 kΩ network	1		kΩ
	Short circuit current		36		mA

<sup>(5)</sup> Time to exit power-down mode into normal mode. Measured from 32nd falling edge SCLK to 90% of DAC final value, Characterized at mid scale.

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## **Electrical Characteristics (continued)**

All minimum/maximum specifications at  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ ,  $2.7 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}$ ,  $2.5 \text{ V} \leq \text{REFIN}^{(1)} \leq \text{VDD}$ ,  $R_{load} = 5 \text{ k}\Omega$  to GND,  $C_{load} = 200 \text{ pF}$  to GND (unless otherwise noted), Digital inputs held at 0 V

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
VOLTA	GE REFERENCE INPUT					
	5	2.7 V ≤ V <sub>DD</sub> ≤ 4.5 V	2.2		$V_{DD} - 0.2$	.,
	Reference input range	4.5 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.2		$V_{DD}$	V
	Reference input current				450	μΑ
	Reference input impedance			15		kΩ
	Reference input capacitance			10		pF
MBW	Multiplying bandwidth			340		kHz
DIGITAL	L INPUTS				1	
$V_{IH}$	High-level input voltage		2.3			V
V <sub>IL</sub>	Low-level input voltage				0.7	V
	Input leakage	0 < V <sub>DIGITAL INPUT</sub> < V <sub>DD</sub>			±1	μA
	Pin capacitance			4		pF
DIGITAL	L OUTPUTS					
V <sub>OH</sub>	High-level output voltage	I <sub>OH</sub> = 2 mA	V <sub>DD</sub> – 1			V
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> = 2 mA			0.7	V
	Pin capacitance			7		pF
POWER	SUPPLY REQUIREMENTS					
$V_{DD}$	Supply voltage		2.7		5.5	V
	Committee and a second	$T_A = -40$ °C to +125°C, Normal mode		4	5.5	mA
I <sub>VDD</sub>	Supply current	$T_A = -40$ °C to +125°C, Power-down mode		3	7	μΑ
	Power dissipation	T <sub>A</sub> = -40°C to +125°C, Normal mode		20		mW
TEMPE	RATURE RANGE					
T <sub>A</sub>	Specified performance		-40		125	°C



## 7.6 DACx0004 Timing Requirements

At  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $T_{rise} = T_{fall} = 1 \text{ nV/sec}$  (10% to 90% of  $V_{DD}$ ) and timed from a voltage level of  $(V_{IL} + V_{IH})/2$ , SDO pin loaded with 10 pF

		4.5 V ≤	$4.5 \text{ V} \le \text{V}_{DD} \le 5.5 \text{ V}$ $2.7 \text{ V} \le \text{V}_{DD} \le 4.5 \text{ V}$			LINUT			
		MIN	TYP	MAX	MIN TYP		MAX	UNIT	
SERIA	L WRITE and READ								
t <sub>c</sub>	SCLK cycle time	20			40			ns	
t <sub>w1</sub>	SCLK high pulse duration	10			20			ns	
t <sub>w2</sub>	SCLK low pulse duration	10			20			ns	
t <sub>su</sub>	SYNC to SCLK falling edge setup time	15			30			ns	
t <sub>su1</sub>	Data setup time	5			10			ns	
t <sub>h1</sub>	Data hold time	5			10			ns	
t <sub>d1</sub>	SCLK falling edge to SYNC rising edge delay time	5			10			ns	
t <sub>w3</sub>	Minimum SYNC high pulse duration (1)	25			35			ns	
t <sub>d2</sub>	SYNC rising edge to SCLK fall ignore delay time	15			20			ns	
t <sub>w4</sub>	LDAC pulse duration low	20			30			ns	
t <sub>d3</sub>	SCLK falling edge to LDAC rising edge delay time	10			20			ns	
t <sub>w5</sub>	CLR minimum pulse duration low	10			20			ns	
t <sub>d4</sub>	SCLK falling edge to LDAC falling edge delay time	10			20			ns	
t <sub>v</sub>	SCLK rising edge to SDO valid time			18			18	ns	
t <sub>d5</sub>	SCLK falling edge to SYNC rising edge delay time	5			10			ns	
t <sub>d6</sub>	SYNC rising edge to SCLK rising edge delay time	5			10			ns	
t <sub>d7</sub>	SYNC rising edge to LDAC or CLR falling edge delay time	20			40			ns	
t <sub>19</sub>	CLR pulse activation time	20			20			ns	
t <sub>20</sub>	Successive DAC Update	2.4			2.4			μs	

#### (1) Does not include output settling tiime

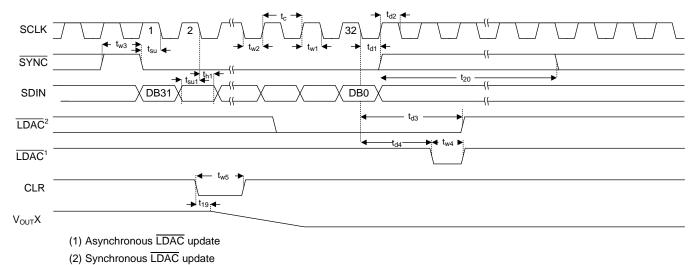


Figure 1. Stand-Alone Timing



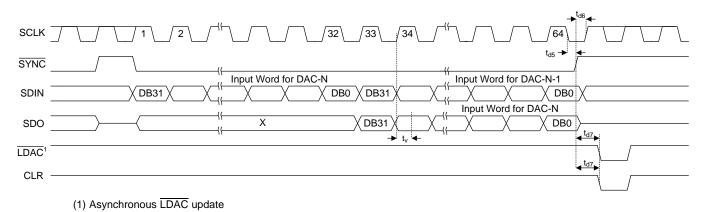
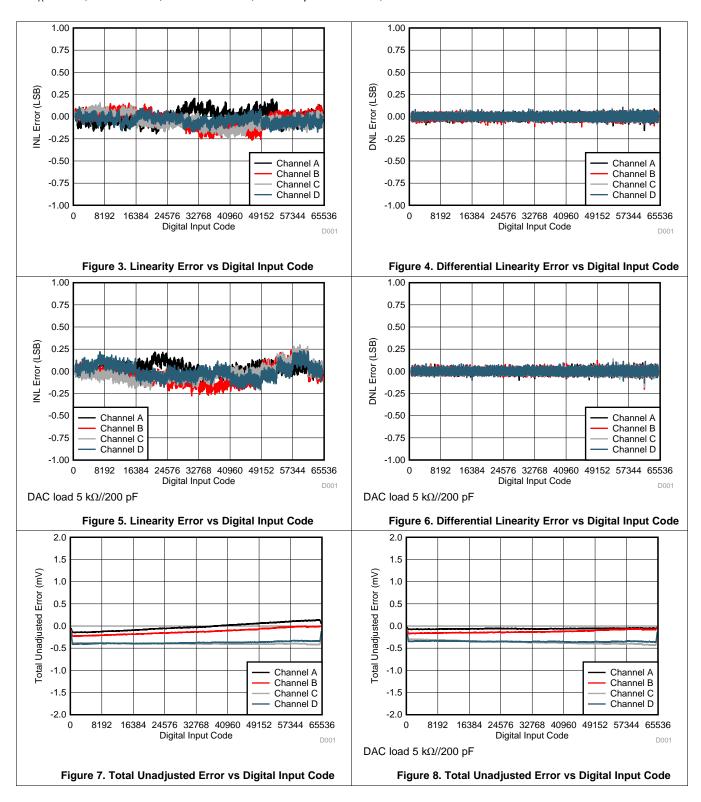


Figure 2. Daisy-Chain Timing



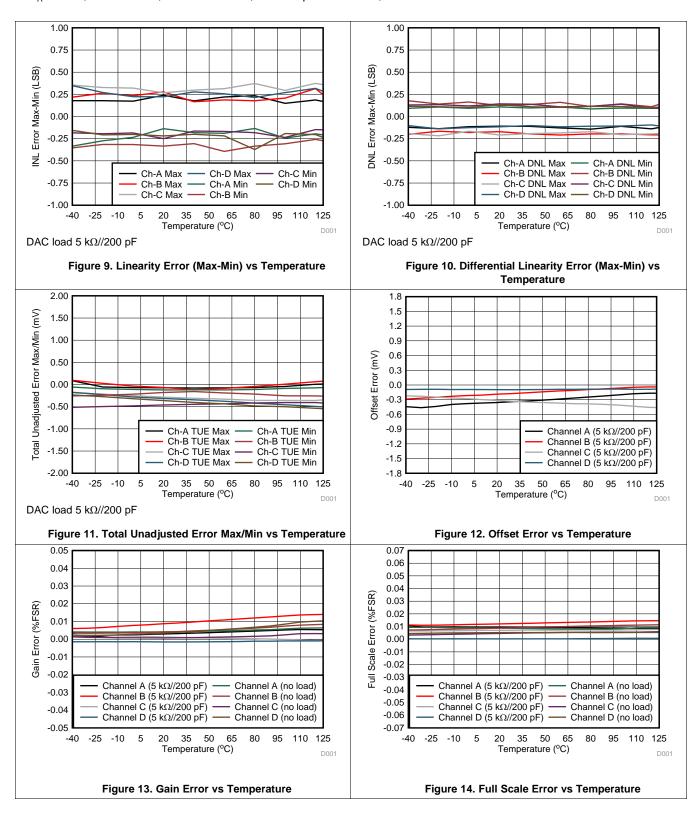
## 7.7 Typical Characteristics

At T<sub>A</sub> = 25°C, VDD = 5.5 V, REFIN = 5.45 V, DAC outputs unloaded, unless otherwise noted.



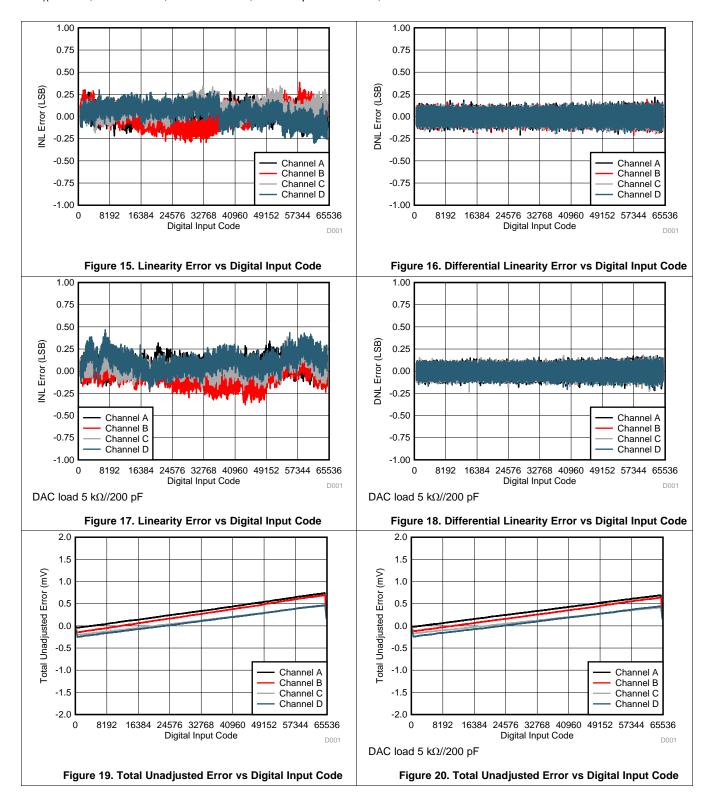


At T<sub>A</sub> = 25°C, VDD = 5.5 V, REFIN = 5.45 V, DAC outputs unloaded, unless otherwise noted.



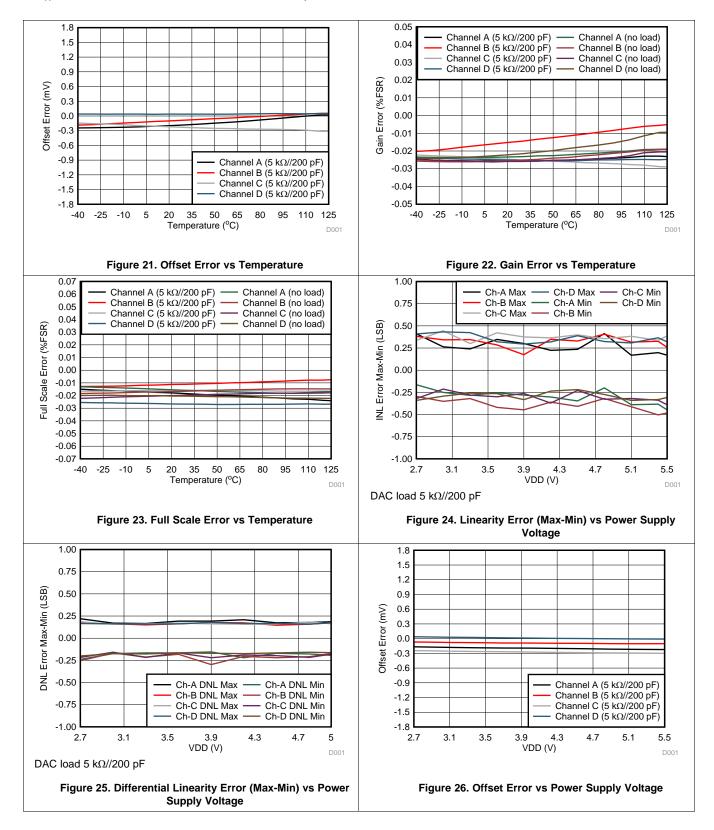


At  $T_A = 25$ °C, VDD = 2.7 V, REFIN = 2.5 V, DAC outputs unloaded, unless otherwise noted.



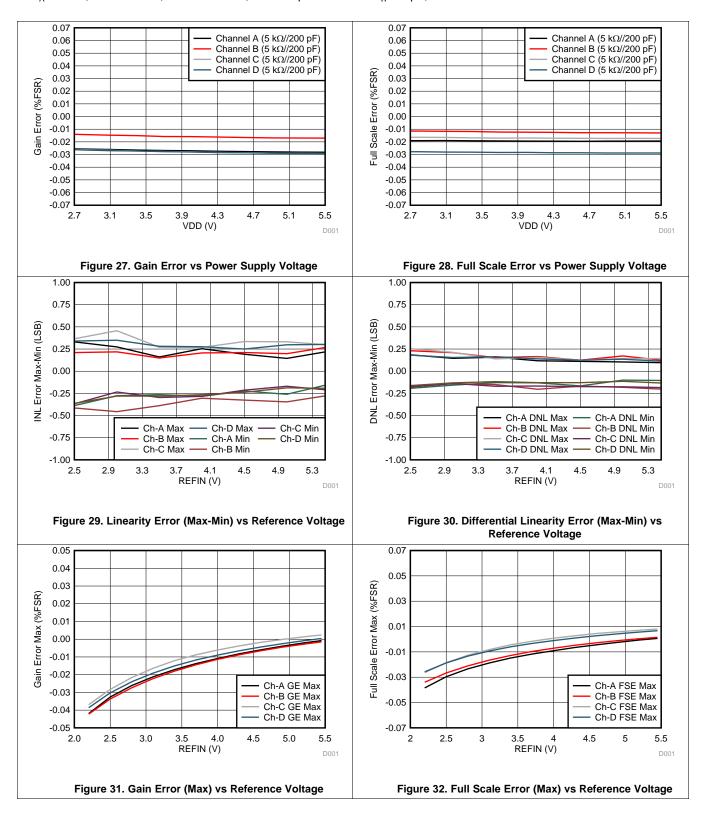


At T<sub>A</sub> = 25°C, VDD = 2.7 V, REFIN = 2.5 V, DAC output unloaded, unless otherwise noted.



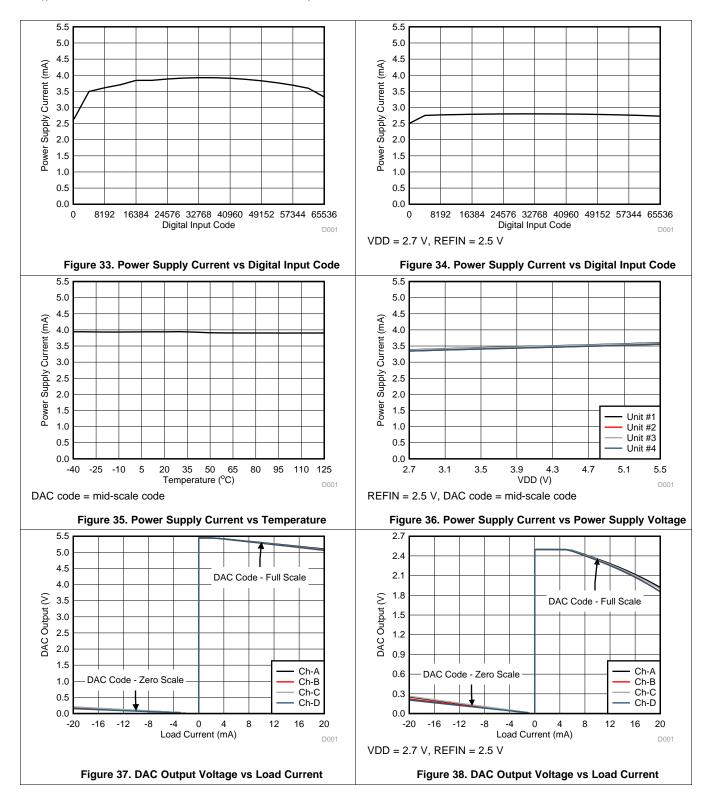


At  $T_A = 25$ °C, VDD = 5.5 V, REFIN = 2.5 V, DAC output load = 5 k $\Omega$ ||200 pF, unless otherwise noted.





At  $T_A = 25$ °C, VDD = 5.5 V, REFIN = 5.45 V, DAC outputs unloaded, All channels active, unless otherwise noted.



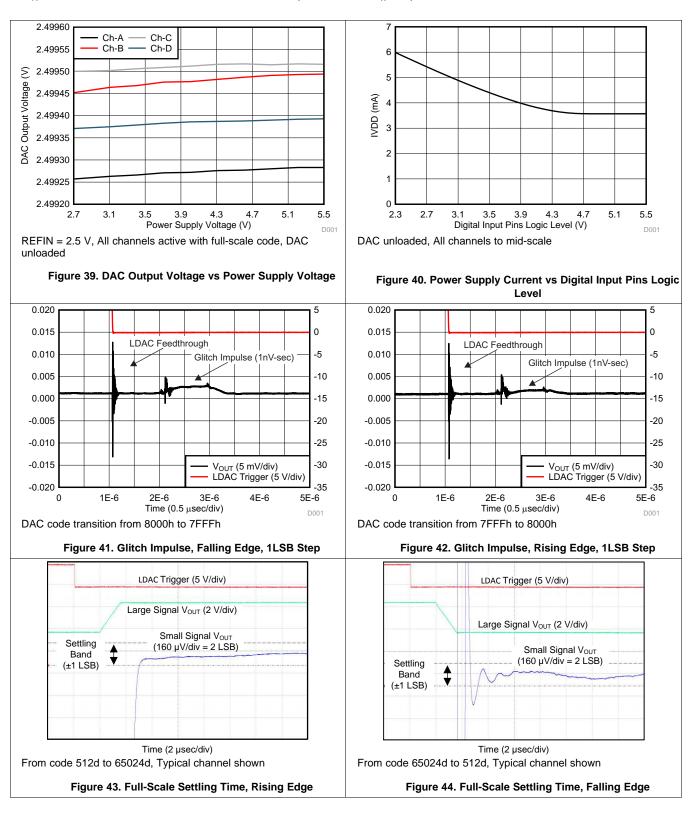
Product Folder Links: DAC80004 DAC70004 DAC60004

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# TEXAS INSTRUMENTS

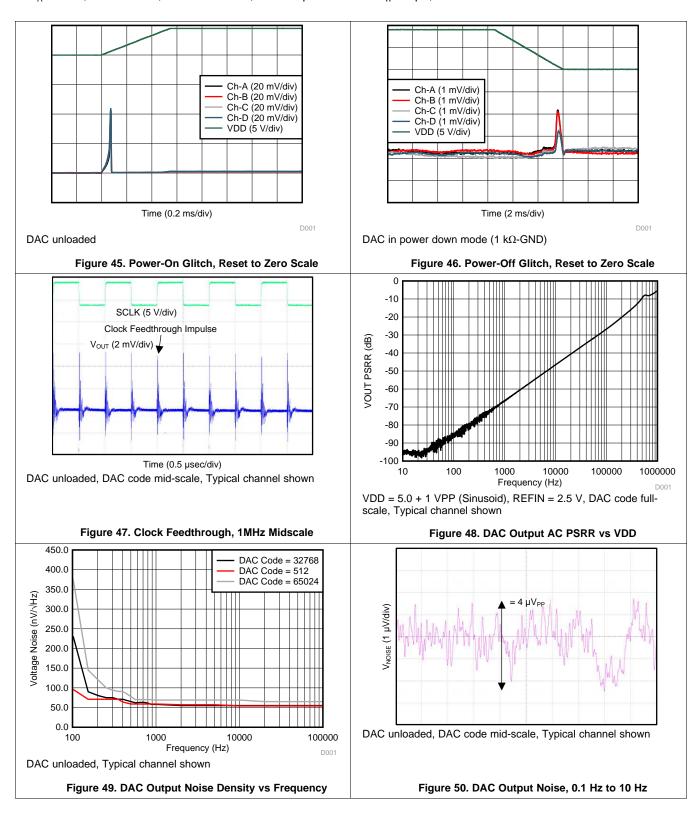
## **Typical Characteristics (continued)**

At  $T_A = 25$ °C, VDD = 5.5 V, REFIN = 5.45 V, DAC output load = 5 k $\Omega$ ||200 pF, unless otherwise noted.





At  $T_A = 25$ °C, VDD = 5.5 V, REFIN = 5.45 V, DAC output load = 5 k $\Omega$ ||200 pF, unless otherwise noted.



Product Folder Links: DAC80004 DAC70004 DAC60004



#### 8 Detailed Description

#### 8.1 Overview

The DAC80004, DAC70004, and DAC60004 are quad-channel, 16-bit, voltage-output DACs with internal reference buffers and output buffers. Each channel consists of an R-2R ladder configuration with the 4 MSBs segmented, followed by an operational amplifier, as shown in Figure 51. The DACx0004 devices have a constant impedance (30 k $\Omega$  typical), buffered reference input. The output of the reference buffers drives the R-2R ladders. With the production trim process these devices have excellent dc accuracy and ac performance.

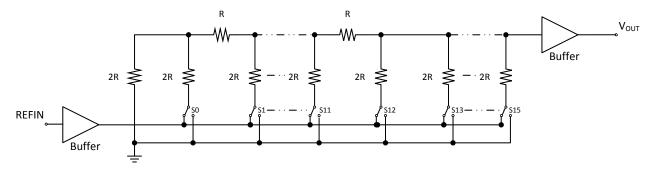


Figure 51. DACx0004 Architecture

The input coding to the DACx0004 is straight binary, so the ideal output voltage is given by Equation 1:

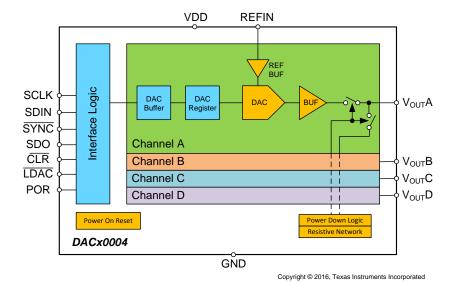
$$V_{OUT} = \left(\frac{D_{IN}}{2^N}\right) \times REFIN$$
 (1)

Where:

N = resolution in bits; either 16 (DAC80004), 14 (DAC70004) or 12 (DAC60004)

 $D_{IN}$  = decimal equivalent of the binary code that is loaded to the DAC register.  $D_{IN}$  ranges from 0 to  $2^N - 1$  REFIN = DAC reference voltage

## 8.2 Functional Block Diagram



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#### 8.3 Feature Description

## 8.3.1 Output Amplifier

The DACx0004 output buffer amplifier is capable of generating near rail-to-rail voltages on its output, giving a maximum output range of 0 V to REFIN. It is capable of driving a load of 5 k $\Omega$  in parallel with 2 nF to GND. The typical slew rate of this amplifier while driving no load is 1.5 V/ $\mu$ s, with a full-scale settling time of 8  $\mu$ s to 1 LSB of the final value as shown in Figure 43 and Figure 44. The current consumption of the amplifier (unloaded) is 1 mA/channel (typical). The DACx0004 output amplifier also implements a short circuit current limiting circuit. The default value of short circuit limit is 40 mA, however this can be reduced to 30 mA using dedicated bits (1 per channel) via SPI command 1010 (see Table 2).

#### 8.3.2 Reference Buffer

The DACx0004 requires an external reference to operate. The reference input pin has the following input range:

2.2 V to 
$$(V_{DD} - 0.2)$$
 for 2.7 V  $\leq V_{DD} \leq 4.5$  V

2.2 V to 
$$V_{DD}$$
 for 4.5 V  $\leq$   $V_{DD} \leq$  5.5 V

The DACx0004 contains a dedicated reference buffer for each DAC channel. The REFIN pin drives the input of these buffers. The integrated reference buffers offers constant impedance of 30 k $\Omega$  (typical) at the REFIN pin. This simplifies the external reference drive circuit for the device.

#### 8.3.3 Power-On Reset

The DACx0004 contain a power-on-reset circuit that controls the output voltage during power up. The power-on reset is useful in applications where it is important to know the state of the output of each DAC while the device is in the process of powering up. At power up all DAC registers are filled with power-on reset code (see Table 1).

#### 8.3.3.1 POR Pin Feature

The DAC power-on reset code for all of the channels depends on the state of the POR pin at power up (see *Pin Configuration and Functions*).

Each DAC channel remains that way until a valid load command is written to it. All device registers are reset at power up as shown in Table 1.

DECICTED NAME	DACx0004 - POWER-ON RESET VALUE
REGISTER NAME	TSSOP-/VSON-14
DAC latches (per channel)	If POR pin = '0' then Zero Scale else Mid scale
DAC buffers (per channel)	If POR pin= '0' then Zero Scale else Mid scale
Power down (per channel)	00 – Normal mode
Clear mode	00 - Clear to Zero
Ignore LDAC (per channel)	0000 – Do not ignore
Daisy chain	0 - Daisy chain disabled, DAC update at 32nd SCLK falling edge
Short circuit limit (per channel)	0000 – all DACs 40 mA

Table 1. DACx0004 Power-On Reset Values

#### 8.3.3.2 Internal Power-On Reset (IPOR) Levels

When the device powers up, an IPOR circuit sets the device in default mode as shown in Table 1. The IPOR circuit requires specific  $V_{DD}$  levels, as indicated in Figure 52, to ensure discharging of internal capacitors and to reset the device on power up. In order to ensure a power-on reset,  $V_{DD}$  must be below 0.7 V for at least 1 ms. When  $V_{DD}$  drops below 2.4 V but remains above 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power supply conditions. In this case, In this case a power-down reset is recommended. When  $V_{DD}$  remains above 2.4 V, a power-on reset does not occur.



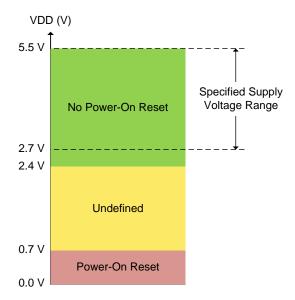


Figure 52. Relevant Voltage Levels for IPOR Circuit

#### 8.4 Device Functional Modes

#### 8.4.1 Serial Interface

The DACx0004 devices have a 4-wire serial interface: SYNC, SCLK, SDIN, and SDO (see *Pin Configuration and Functions*). The serial interface (3-wire and 4-wire) is compatible with SPI, QSPI, and Microwire interface standards, as well as most DSPs and it operates up to 50 MHz. See the Write Mode Stand-Alone Timing and Write Mode Daisy-Chain Timing diagrams (see Figure 1 and Figure 2) for examples of typical write and read sequences. The input shift register is 32 bits wide.

#### 8.4.1.1 Stand-Alone Mode

The serial clock SCLK can be a continuous or a gated clock. The first falling edge of SYNC starts the operation cycle. When SYNC is high, the SCLK and SDIN signals are blocked and the SDO pin (TSSOP-14 and VSON-14 packages) is in a Hi-Z state. The device internal registers are updated from the shift register on the 32nd falling edge of SCLK.

#### 8.4.1.1.1 SYNC Interrupt – Stand-Alone Mode

For stand-alone operation, the SYNC line stays low for at least 32 falling edges of SCLK and the addressed DAC register updates on the 32nd SCLK falling edge. However, if SYNC is brought high before the 32nd SCLK falling edge, it acts as an interrupt to the write sequence; the shift register resets and the write sequence is discarded. Neither an update of the data buffer contents, DAC register contents, nor a change in the operating mode occurs (as shown in Figure 53).

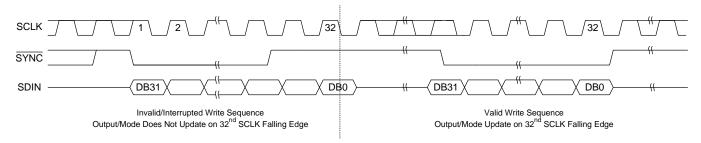


Figure 53. SYNC Interrupt – Stand Alone Operation

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#### **Device Functional Modes (continued)**

#### 8.4.1.1.2 Read-Back Mode

The READ command is used to start read-back operation. However, before read-back operation can be initiated, the SDO pin must be enabled by setting the DSDO bit to '1'; this bit is disabled by default. Read-back operation is then started by executing a READ command (R/W bit = '1', see Table 3). Bits C3 to C0 select the register to be read. The remaining data in the command are don't care bits. During the next SPI operation, the data appearing on the SDO output are from the previously addressed register. For a read of a single register, a NOP (No Operation) command (1110) can be used to clock out the data from the selected register on SDO. Multiple registers can be read if multiple READ commands are issued (see Figure 54).

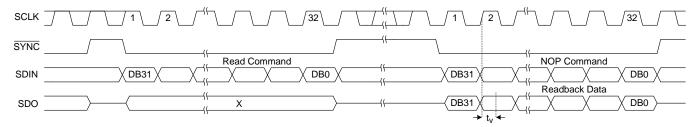


Figure 54. Read-Back Operation

#### 8.4.1.2 Daisy-Chain Mode

For systems that contain more than one device, the SDO pin can be used to daisy-chain multiple devices together (see Figure 55). Daisy-chain operation can be useful in system diagnostics and in reducing the number of serial interface lines. The daisy-chain feature can be enabled by writing a logic '1' to the DSDO bit (see Table 3); the SDO pin is set to HIZ when the DSDO bit is set to 0.

The first falling edge of  $\overline{\text{SYNC}}$  starts the operating cycle. SCLK is continuously applied to the SPI shift register when  $\overline{\text{SYNC}}$  is low. If more than 32 clock pulses are applied, the data ripples out of the shift register and appear on the SDO line. The data bits are clocked out on the rising edge of SCLK and are valid on the falling edge. By connecting the SDO pin of the first device to the SDI input of the next device in the chain, a multiple-device interface is constructed (see Figure 2). Each device in the system requires 32 clock pulses. Therefore, the total number of clock cycles must equal  $32 \times N$ , where N is the total number of DACx0004s in the chain. When the serial transfer to all devices is complete,  $\overline{\text{SYNC}}$  is taken high. This action latches the data from the SPI shift registers to the device internal registers for each device in the daisy-chain and prevents any further data from being clocked in. The serial clock can be a continuous or a gated clock. Note that a continuous SCLK source can only be used if  $\overline{\text{SYNC}}$  is held low for the correct number of clock cycles. For gated clock mode, a burst clock containing the exact number of clock cycles must be used and  $\overline{\text{SYNC}}$  must be taken high after the final clock in order to latch the data.

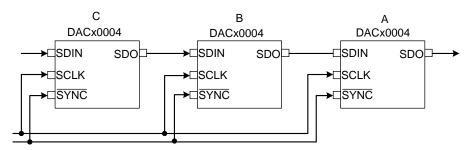


Figure 55. DACx0004 in Daisy Chain Mode

#### 8.4.1.2.1 SYNC Interrupt – Daisy-Chain Mode

For daisy-chain operation, the  $\overline{\text{SYNC}}$  line stays low for at least 32 x N SCLK cycles, where N is the number of DACx0004s in the daisy chain. If  $\overline{\text{SYNC}}$  is brought high before a multiple 32 SCLKs, it acts as an interrupt to the write sequence; the shift register resets and the write sequence is discarded. Neither an update of the data buffer contents, DAC register contents, nor a change in the operating mode occurs (see Figure 56).

#### **Device Functional Modes (continued)**

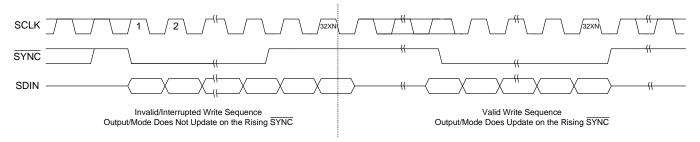


Figure 56. SYNC Interrupt – Daisy-Chain Operation

## 8.4.2 SPI Shift Register

The SPI shift register is 32 bits wide, as shown in Table 2. The shift register command mapping is shown in Table 3. The DACx0004 accepts DAC code in straight binary format. Note that, the DAC data is left alligned from MSB (D19) to LSB (D4 - 16 bits, D6 - 14 bits, D8 - 12 bits).

## Table 2. DACx0004 SPI Shift Register Format

D3 <sup>-</sup>	D30	D29	D28	D27-D24	D23-D20	D19-D04	D03-D00
	Don't Car	es	R/W	Command Bits	Channel Address Bits	16/14/12-Bit DAC Data left alligned/Power Down Bits/Device Ready bit	Mode Bits

#### **Table 3. DAC Commands**

D31	D31 - D28 D27 - D24		D23 - D20	D19 - D16	D15 - D12	D11 - D08		D07 - D04		D03 - D00				Commands			
Х	W/R	0	0	0	0	Channel Address	DAC Data	DAC Data	DAC Da	ata	DAC	Data Data		×			Write to buffer n
х	W	0	0	0	1	Channel Address	х	X	х			Х		Х			Update DAC n
х	W	0	0	1	0	Channel Address	DAC Data	DAC Data	DAC Da	C Data DAC Data X			Write to buffer n and update all DACs (Software LDAC)				
Х	W	0	0	1	1	Channel Address	DAC Data	DAC Data	DAC Da	ata	DAC	C Data	х			Write to buffer and update DAC n	
Х	W/R	0	1	0	0	Х	Х	X	X PD1	PD0			Ch-D	Ch-C	Ch-B	Ch-A	Power up/down DAC n
Х	W/R	0	1	0	1	Х	Х	Х	Х	Х		Χ	Х	Х	CM1	СМО	Clear mode register
Х	W/R	0	1	1	0	Х	Х	Х	Х			Χ	Ch-D	Ch-C	Ch-B	Ch-A	LDAC register
Х	W	0	1	1	1	Х	Х	Х	Х			Χ	X			Software reset	
х	W/R	1	0	0	0	Х	х	Х	х			Х		Κ	DSD 0	х	Disable SDO register
Х	Х	1	0	0	1	Х	Х	Х	Х			Χ		)	K		Reserved
Х	W/R	1	0	1	0	Х	Х	Х	Х			Х	Ch-D	Ch-C	Ch-B	Ch-A	Short circuit limit register
Х	W	1	0	1	1	Х	Х	Х	Х		X X			Software clear			
Х	Х	1	1	0	0	Х	Х	Х	Х			Χ		)	Κ		Reserved
Х	R	1	1	0	1	Х	Х	Х	Х		X DRDY		X			Status register	
Х	W	1	1	1	0	Х	Х	Х	X X		x x				No operation (NOP)		
Х	Х	1	1	1	1	Х	Х	Х	Х			Х		)	K		Reserved

**Table 4. Channel Address Bits** 

	CHANNEL	ADDRESS BITS	8	DESCRIPTION			
D23	D22	D21	D20	DESCRIPTION			
0	0	0	0	Select channel A			
0	0	0	1	Select channel B			
0	0	1	0	Select channel C			
0	0	1	1	Select channel D			
1	1	1	1	Select all channel			

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#### 8.4.3 DAC Power-Down Modes

The DACx0004 use four modes of operation. These modes are accessed by setting command bits D28 – D24 and power-down register bits D09 and D08. The command bits must be set to 0100 (see Table 3). Once the command bits are set correctly, the four different power-down modes are software programmable by setting bits D09 and D08 in the shift register. Table 5 shows how to control the operating mode with data bits PD1 (D09), PD0 (D08).

Table 5. Power-Down Bits	
DESCRIPTION	

POWER DOWN BITS		DESCRIPTION				
D09	D08	DESCRIPTION				
0	0	Normal operation/power up selected channel(s) (Default)				
0	1	Power down selected channel(s) 1 kΩ-GND				
1	0	Power down selected channel(s) 100 kΩ-GND				
1	1	Power down selected channel(s) Hi-Z				

It is possible to write to the DAC register/buffer of the DAC channel that is powered down. When the DAC channel is then powered up, it powers up to this new value.

The advantage of the available power-down modes is that the output impedance of the device is known while it is in power-down mode. As described in Table 5, there are three different power-down options.  $V_{OUT}X$  can be connected internally to GND through a 1 k $\Omega$  resistor, a 100 k $\Omega$  resistor, or open-circuited (Hi-Z). The DAC power-down circuitry is shown in Figure 57.

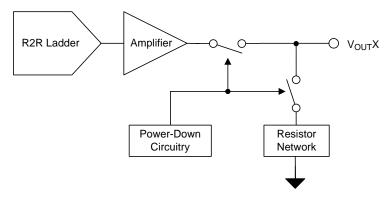


Figure 57. DACx0004 Power Down

## 8.4.4 CLR Pin Functionality and Software CLEAR Mode

The  $\overline{\text{CLR}}$  pin is an asynchronous input pin to the DAC. When activated, this falling edge sensitive pin clears the DAC buffers and the DAC latches to zero, mid, full or user programmed code depending on the clear mode register (see Table 6). The default setting for clear operation is clear to 0 V. The device exits clear mode on the 32nd falling edge of the next write to the device. If the  $\overline{\text{CLR}}$  pin receives a falling edge signal during a write sequence in normal operation, the clear mode is activated and changes the input and DAC registers immediately. Additionally, all DAC registers can also be cleared via SPI command 1011. Note that the clear mode bits determine the clear code for all the DACs upon clear operation.

#### 8.4.4.1 DAC Clear Mode Registers

The DACx0004 implement four different clear modes. These modes are accessed by setting command bits D28 – D24 and clear mode register bits D01 and D00. The command bits must be set to 0101 (see Table 3). Based on the value of clear mode register (see Table 6), all of the DAC and the buffers are cleared to zero, mid, or full-scale code, when the  $\overline{\text{CLR}}$  pin sees a falling edge or after a software clear command is issued.

The user defined clear scale can be set by writing 16-/14-/12- data to 1001 to bits D28 – D24.



#### **Table 6. Clear Mode Bits**

CLEAR MODE BITS		DESCRIPTION					
D01	D00	DESCRIPTION					
0	0	All DACs clear to zero scale (default)					
0	1	All DACs clear to mid scale					
1	0	All DACs clear to full scale					

## 8.4.5 **LDAC** Pin Functionality

The DACx0004 devices offer both a software and hardware simultaneous update and control function. The DAC double-buffered architecture has been designed so that new data can be entered for each DAC without disturbing the analog outputs. Data updates can be performed either in synchronous or in asynchronous mode.

In asynchronous mode, the  $\overline{\text{LDAC}}$  pin is used as an active low signal for simultaneous DAC updates. Multiple single-channel writes can be done in order to set different channel buffers to desired values and then pulse the  $\overline{\text{LDAC}}$  pin low to simultaneously update the DAC output registers. Data buffers of all channels must be loaded with desired data before an  $\overline{\text{LDAC}}$  low pulse. After a  $\overline{\text{LDAC}}$  low pulse, all DACs are simultaneously updated with the last contents of the corresponding data buffers. If the content of a data buffer is not changed, the corresponding DAC output remains unchanged after the  $\overline{\text{LDAC}}$  pin is pulsed low.

In synchronous mode, data are updated with the falling edge of the 32nd SCLK cycle, which follows a falling edge of SYNC. For such synchronous updates, the LDAC pin is not required, and it must be connected to GND permanently or asserted and held low before sending commands to the device.

#### 8.4.5.1 Software LDAC Mode Registers

Alternatively, all DAC outputs can be updated simultaneously using the built-in software function of  $\overline{\text{LDAC}}$ . The  $\overline{\text{LDAC}}$  register offers additional flexibility and control by allowing the selection of which DAC channel(s) should be updated simultaneously when the  $\overline{\text{LDAC}}$  pin is being brought low. The  $\overline{\text{LDAC}}$  register is loaded with a 4-bit word (D03 and D00) using command bits  $\overline{\text{D28}}$  – D24 (see  $\overline{\text{Table 3}}$ ). The default value for each bit, and therefore for each DAC channel, is zero. If the  $\overline{\text{LDAC}}$  register bit is set to 1, it overrides the  $\overline{\text{LDAC}}$  pin (the  $\overline{\text{LDAC}}$  pin is internally tied low for that particular DAC channel), and this DAC channel updates synchronously after the falling edge of the 32nd SCLK cycle. However, if the  $\overline{\text{LDAC}}$  register bit is set to 0, the DAC channel is controlled by the  $\overline{\text{LDAC}}$  pin.

See Table 7 for more information.

Table 7. LDAC Register

LDAC REGISTER BITS (D03 – D00)	DAC UPDATE
0	Determined by LDAC pin (Default)
1	DAC channel ignores LDAC pin, DAC updates on 32nd falling edge of SCLK, DAC channels see LDAC as 0

#### 8.4.6 Software Reset Mode

The DACx0004 implements a software reset feature. The software reset function uses command bits D28 – D24 (see Table 3). Table 1 shows the reset values for different registers.

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#### 8.4.7 Output Short Circuit Limit Register

The DACx0004 output amplifier has a default short circuit limit of 40 mA. However, this limit can be reduced to 30 mA by using command 1010 on bits D28 – D24 and selecting channel(s) (D03 – D00). Please note that DACx0004 has a dedicated bit per channel, this allows the user to set different short circuit limit for different DAC output channels.

**Table 8. Short Circuit Limit Register** 

SHORT CIRCUIT LIMIT REGISTER BITS (D03 – D00)	DAC SHORT CIRCUIT LIMIT
0	DAC output short circuit limit = 40 mA (Default)
1	DAC output short circuit limit = 30 mA

## 8.4.8 Status Register

The DACx0004 implements a read-only status register (see Table 3). This register can be read by using command 1101 on bits D28 – D24, followed by a NOP command.

Logic '1' on bit D04 indicates that the device is ready to be used. This feature is useful to check if the device is ready to accept commands after power up.



## 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Application Information

#### 9.2 Typical Application - Digitally Controlled Asymmetric Bipolar Output

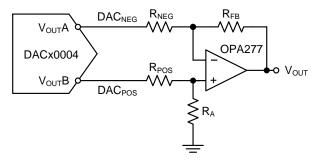


Figure 58. Asymmetric Bipolar Output Block Diagram

## 9.2.1 Design Requirements

This design requires two channels of the DACx0004 to generate a bipolar output. The design is very flexible and allows for many different configurations. Typically, one channel is used to finely control the output, while the other is used to offset the output. The direction of the offset depends on which channel is used as an offset. DAC<sub>POS</sub> provides a positive offset and DAC<sub>NEG</sub> has a negative offset.

#### 9.2.2 Detailed Design Procedure

The output of each DAC can be modified via the digital interface and the gain of each output can be modified independently by changing the external resistors. In order for the gain of each offset to be independent, Equation 2 must be true.

$$R_{A} = \left(\frac{1}{R_{FB}} + \frac{1}{R_{NEG}} - \frac{1}{R_{POS}}\right)^{-1}$$
(2)

The output voltage range,  $V_{OUT}$ , is adjusted according to Equation 3. Keep in mind that Equation 3 is only true when Equation 2 is true.

$$V_{OUT} = DAC_{POS} \times \frac{R_{FB}}{R_{POS}} - DAC_{NEG} \times \frac{R_{FB}}{R_{NEG}}$$
(3)

Each DAC outputs a voltage from 0 to REFIN. As an example, if DAC<sub>POS</sub> gain is 1, DAC<sub>NEG</sub> gain is 2 and R<sub>FB</sub> =  $2 \text{ k}\Omega$ , then R<sub>POS</sub> =  $2 \text{ k}\Omega$ , R<sub>NEG</sub> =  $1 \text{ k}\Omega$  and R<sub>A</sub> =  $1 \text{ k}\Omega$ . With the correct digital implementation it gives the output an effective output range of ±15 V, with discrete 16-bit steps.

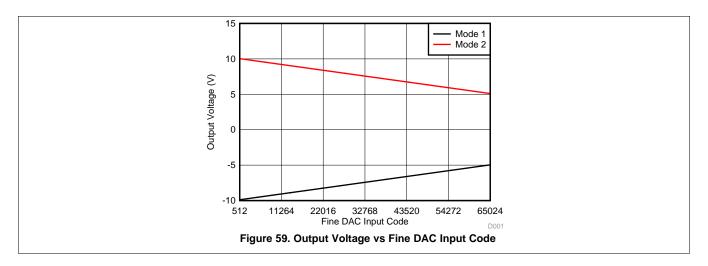
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## Typical Application - Digitally Controlled Asymmetric Bipolar Output (continued)

## 9.2.3 Application Curve

Figure 59 displays two different modes of operation. Mode 1 gains the output of  $DAC_{Neg}$  by a factor of 2 and maintains  $DAC_{POS}$  at unity gain. Mode 2 reverses the gains of each stage to invert the system. These are just two examples of the types of outputs that can be achieved using this configuration.





## 10 Power Supply Recommendations

The DACx0004 can operate within the specified supply voltage range of 2.7 V to 5.5 V. The power applied to VDD should be well-regulated and have low-noise. Switching power supplies and DC-DC converters often have high frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high frequency spikes. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output. A 1  $\mu$ F to 10  $\mu$ F capacitor and 0.1  $\mu$ F bypass capacitor is recommended in order to further minimize noise from the power supply. The current consumption on the VDD pin, the short-circuit current limit, and the load current for the device are listed in the *Electrical Characteristics*. The power supply must meet the aforementioned current requirements.

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## 11 Layout

## 11.1 Layout Guidelines

A precision analog component requires careful layout, adequate bypassing, and clean, well-regulated power supplies. As a general rule it is important to keep digital traces as far away from analog traces when possible.

The DACx0004 is often used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to keep digital noise from appearing at the output.

Due to the single ground pin of the DACx0004, all return currents, including digital and analog return currents for the DAC, must flow through a single point. Ideally, GND must be connected directly to an analog ground plane. This plane must be separate from the ground connection for the digital components until they were connected at the power-entry point of the system.

As with the GND connection, VDD should be connected to a 5 V power-supply plane or trace that is separate from the connection for digital logic until they are connected at the power-entry point. It is recommended to have an additional 1  $\mu$ F to 10  $\mu$ F capacitor and 0.1  $\mu$ F bypass capacitor. In some situations, additional bypassing may be required, such as a 100  $\mu$ F electrolytic capacitor or even a Pi filter made up of inductors and capacitors—all designed to essentially low-pass filter the 5 V supply, removing the high-frequency noise. In general it is always a good idea to maintain the digital signals away from analog signals.

#### 11.2 Layout Example

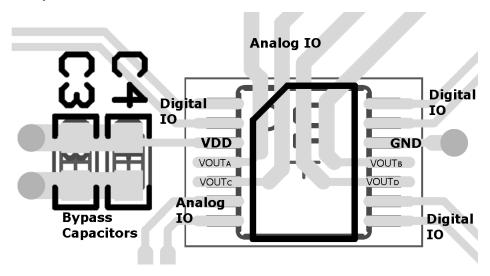


Figure 60. Layout Diagram



## 12 Device and Documentation Support

#### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
DAC60004	Click here	Click here	Click here	Click here	Click here	
DAC70004	Click here	Click here	Click here	Click here	Click here	
DAC80004	Click here	Click here	Click here	Click here	Click here	

## 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.4 Trademarks

E2E is a trademark of Texas Instruments.

SPI, QSPI are trademarks of Motorola.

All other trademarks are the property of their respective owners.

#### 12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

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## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

DAC80004IPW Device Marking Addendum: Note that both DA80004 and XDC84 are valid Device Markings for the DAC80004IPW Orderable Device

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## **PACKAGE OPTION ADDENDUM**



10-Dec-2020

#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
DAC60004IDMDR	ACTIVE	VSON	DMD	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA60004	Samples
DAC60004IDMDT	ACTIVE	VSON	DMD	14	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA60004	Samples
DAC60004IPW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA60004	Samples
DAC60004IPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA60004	Samples
DAC70004IDMDR	ACTIVE	VSON	DMD	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA70004	Samples
DAC70004IDMDT	ACTIVE	VSON	DMD	14	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA70004	Samples
DAC70004IPW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA70004	Samples
DAC70004IPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA70004	Samples
DAC80004IDMDR	ACTIVE	VSON	DMD	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA80004	Samples
DAC80004IDMDT	ACTIVE	VSON	DMD	14	250	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA80004	Samples
DAC80004IPW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA80004	Samples
DAC80004IPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	DA80004	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

## PACKAGE OPTION ADDENDUM



10-Dec-2020

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC60004IDMDR	VSON	DMD	14	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC60004IDMDT	VSON	DMD	14	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC60004IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
DAC70004IDMDR	VSON	DMD	14	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC70004IDMDT	VSON	DMD	14	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC70004IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
DAC80004IDMDR	VSON	DMD	14	3000	330.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC80004IDMDT	VSON	DMD	14	250	180.0	12.4	3.3	4.3	1.1	8.0	12.0	Q1
DAC80004IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DAC60004IDMDR	VSON	DMD	14	3000	367.0	367.0	38.0
DAC60004IDMDT	VSON	DMD	14	250	213.0	191.0	35.0
DAC60004IPWR	TSSOP	PW	14	2000	356.0	356.0	35.0
DAC70004IDMDR	VSON	DMD	14	3000	367.0	367.0	38.0
DAC70004IDMDT	VSON	DMD	14	250	213.0	191.0	35.0
DAC70004IPWR	TSSOP	PW	14	2000	356.0	356.0	35.0
DAC80004IDMDR	VSON	DMD	14	3000	367.0	367.0	38.0
DAC80004IDMDT	VSON	DMD	14	250	213.0	191.0	35.0
DAC80004IPWR	TSSOP	PW	14	2000	356.0	356.0	35.0





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## **TUBE**

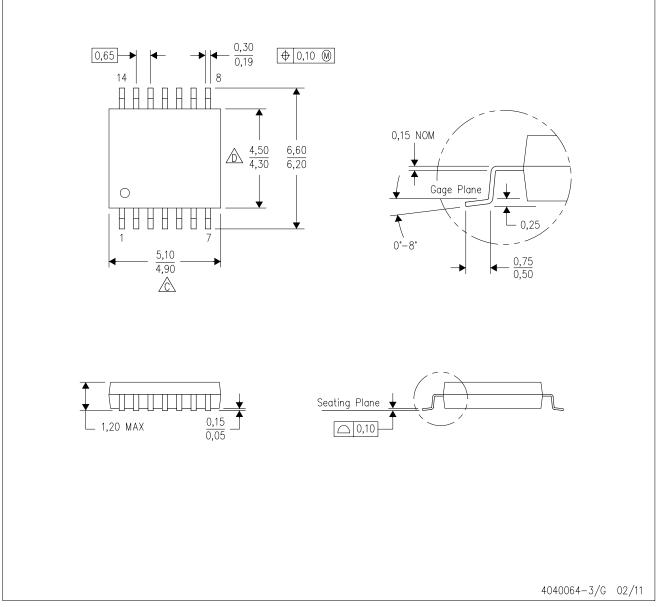


#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
DAC60004IPW	PW	TSSOP	14	90	530	10.2	3600	3.5
DAC70004IPW	PW	TSSOP	14	90	530	10.2	3600	3.5
DAC80004IPW	PW	TSSOP	14	90	530	10.2	3600	3.5

PW (R-PDSO-G14)

## PLASTIC SMALL OUTLINE



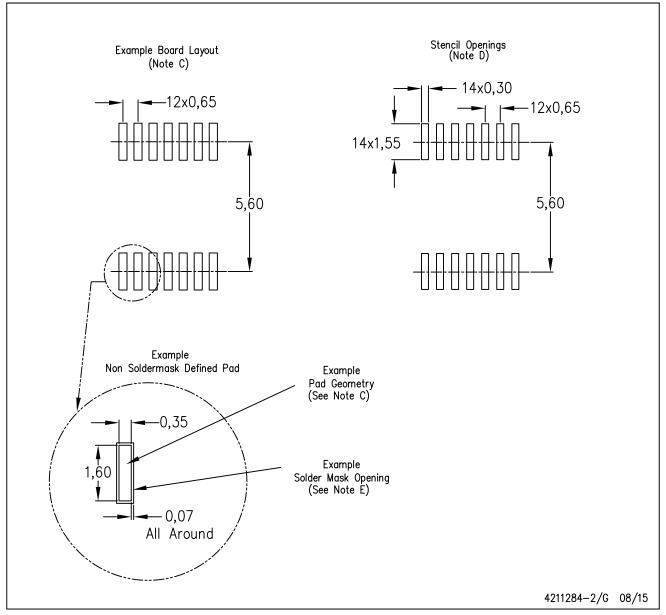
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



# PW (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





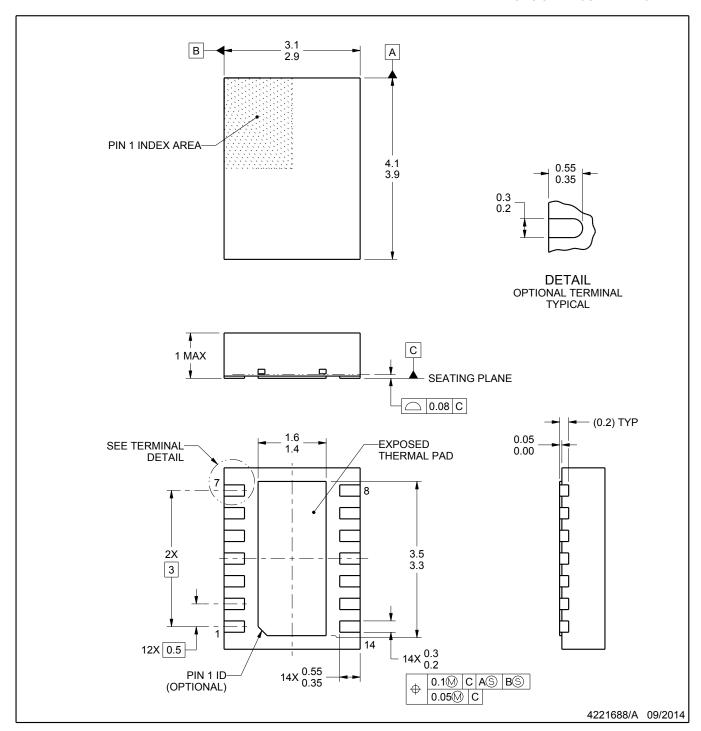
Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4221533/B





PLASTIC SMALL OUTLINE - NO LEAD



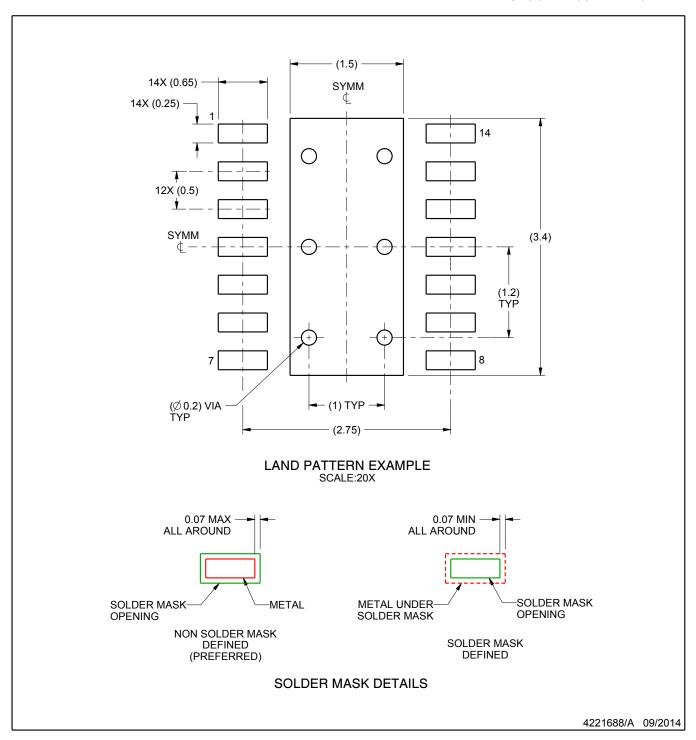
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

PLASTIC SMALL OUTLINE - NO LEAD

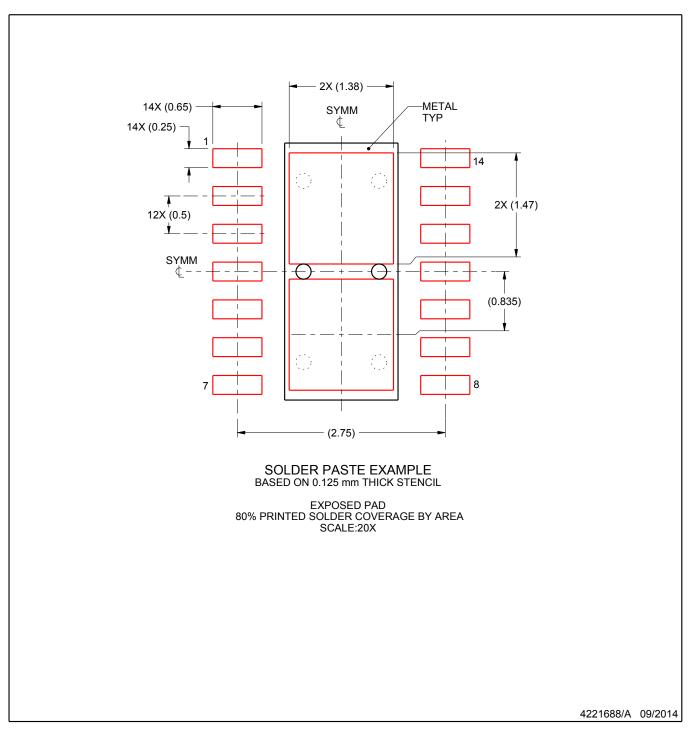


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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